Notice of References Cited Application/Control No. 10/716,672 Applicant(s)/Patent Under Reexamination HARADA ET AL. Examiner Dah-Wei D. Yuan Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,740,436	04-1988	Kobayashi et al.	429/213
*	В	US-4,992,559	02-1991	Kathirgamanathan et al.	549/65
*	С	US-6,110,563	08-2000	Pienimaa et al.	428/137
	D	US-			
	Е	US-			
	F	US-			
	G	US-			,
	Н	US-			
	ı	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 61-206170	09-1986	Japan	Hirai et al.	H01M 4/60
	0					
	Р					
	Q					
	R					·
	s		•			
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.